Search Notes				

Application/Control No.

Applicant(s)/Patent under Reexamination

HAYASHI ET AL.

10/085,607

Examiner

Art Unit

Monica Lewis

2822

SEARCHED				
Class	Subclass	Date	Examiner	
257	57,59, 72,79, 80,84	10/29/2005	ML	
		F		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Interferen	ce Search	10/29/2005	ML	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EIC Search	10/29/2005	ML	
East Search	10/29/2005	ML	
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